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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/678,997	YOVICHIN ET AL.	
Examiner	Art Unit	
James Mackey	1722	

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Class	Subclass	Date	Examiner
425	35, 40, 47, 50, 54, 55, 57	11/14/2005	JPM

INI	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH NOT (INCLUDING SEARCH	ES STRATEGY))
-	DATE	EXMR
Conducted INVENTOR name search in IFW	11/14/2005	JPM